MSKSEMI 美森科



ESD





TSS



MOV



GDT



PIFF

AOD603A-MS

Product specification





FEATURES

- Fast switching
- Green Device Available
- Suit for 4.5V Gate Drive Applications

Applications

- DC Fan
- Motor DriveApplications
- Networking
- Half / Full Bridge Topology

BVDSS	RDSON	ID
60V	45mΩ	13A
-60V	90mΩ	-13A

Reference News

PACKAGE OUTLINE	Pin Configuration	Marking
TO-252-4L	D1/D2 G1 G2 S1 S2	MSKSEMI AOD603A MS XXX

Absolute Maximum Ratings Tc=25℃ unless otherwise noted

Symbol	Parameter	Rat	ting	Units
Vos	Drain-Source Voltage	60	-60	V
Vgs	Gate-Source Voltage	±20	±20	V
	Drain Current - Continuous (Tc=25°C)	13	13	Α
lb .	Drain Current - Continuous (Tc=100°C)	9.5	9.5	Α
Ірм	Drain Current - Pulsed ¹	30	30	Α
EAS	Single Pulse Avalanche Energy ²	18	31	mJ
IAS	Single Pulse Avalanche Current ²	19	25	Α
D-	Power Dissipation (Tc=25°C)	20.	1	W
Po	Power Dissipation - Derate above 25°C	0.1	6	W/°C
Тѕтс	Storage Temperature Range	-55 to 150		°C
TJ	Operating Junction Temperature Range	-55 to	150	°C

Thermal Characteristics

Symbol	Parameter	Тур.	Max.	Unit
Reuc	Thermal Resistance Junction to Case		6.2	°C/W
Reja	Thermal Resistance Junction to Ambient		62	°C/W



N-CH Electrical Characteristics (T_J=25 °C, unless otherwise)

Off Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V _G s=0V , I _D =250uA	60			V
△BVbss/△TJ	BV _{DSS} Temperature Coefficient	Reference to 25°C , I _D =1mA		0.07		V/°C
	During Common Lordon or Commont	V _{DS} =60V , V _{GS} =0V , T _J =25°C			1	uA
I _{DSS}	Drain-Source Leakage Current	V _{DS} =48V , V _{GS} =0V , T _J =125°C			10	uA
Igss	Gate-Source Leakage Current	V _{GS} =±20V , V _{DS} =0V			±100	nA

On Characteristics

Danier	Static Drain-Source On-Resistance	V _{GS} =10V , I _D =12A		45	60	mΩ
R _{DS(ON)} Static Drain-So	Static Dialii-Source Oil-Resistance	V _{GS} =4.5V , I _D =8A		60	80	mΩ
$V_{GS(th)}$	Gate Threshold Voltage	V _{GS} =V _{DS} , I _D =250uA	1.0	1.6	2.5	V
$\triangle V_{\text{GS(th)}}$	V _{GS(th)} Temperature Coefficient			-4.6		mV/°C
gfs	Forward Transconductance	V _{DS} =10V , I _D =3A		10		S

Dynamic and switching Characteristics

- ya	, and switching onalactor.	31103		
Qg	Total Gate Charge 3,4		 16.6	
Qgs	Gate-Source Charge ^{3, 4}	V _{DS} =30V , V _{GS} =10V , I _D =10A	 2.2	 nC
Qgd	Gate-Drain Charge ^{3,4}		 3.9	
Td(on)	Turn-On Delay Time ^{3,4}		 4.6	
Tr	Rise Time ^{3, 4}	V_{DD} =30 V , V_{GS} =10 V , R_{G} =6 Ω	 14.8	
Td(off)	Turn-Off Delay Time ^{3,4}	lo=1A	 27.2	 ns
Tf	Fall Time ^{3, 4}		 7.8	
Ciss	Input Capacitance		 1180	
Coss	Output Capacitance	V _{DS} =30V , V _{GS} =0V , F=1MHz	 68	 pF
Crss	Reverse Transfer Capacitance		 45	
Rg	Gate resistance	V _{GS} =0V, V _{DS} =0V, F=1MHz	 2.1	 Ω

Drain-Source Diode Characteristics and Maximum Ratings

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
ls	Continuous Source Current	V _G =V _D =0V , Force Current			13	Α
Іѕм	Pulsed Source Current				26	Α
Vsp	Diode Forward Voltage	V _G s=0V , I _S =1A , T _J =25°C			1.2	V

Note:

- 1. Repetitive Rating : Pulsed width limited by maximum junction temperature.
- 2. V_{DD} =25V, V_{GS} =10V,L=0.1mH, N-CH I_{AS}=23A., P-CH I_{AS}=33A, R_G=25 Ω , Starting T_J=25 $^{\circ}$ C.
- 3. The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%.
- 4. Essentially independent of operating temperature.



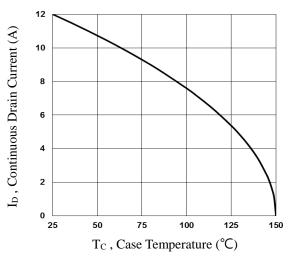


Fig.1 Continuous Drain Current vs. Tc

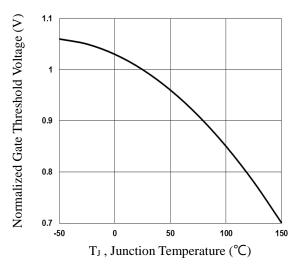


Fig.3 Normalized V_{th} vs. T_J

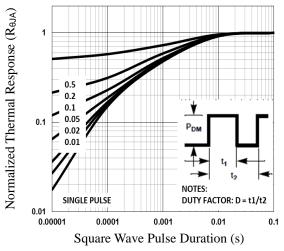


Fig.5 Normalized Transient Impedance

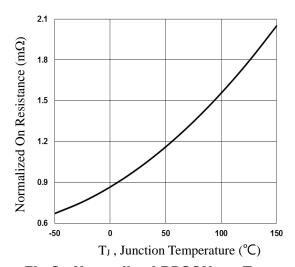


Fig.2 Normalized RDSON vs. TJ

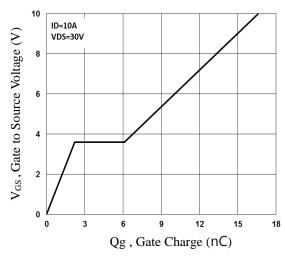


Fig.4 Gate Charge Waveform

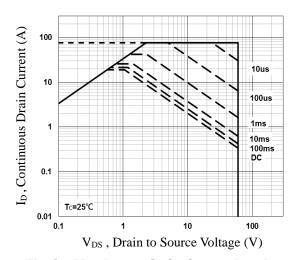


Fig.6 Maximum Safe Operation Area



P-CH Electrical Characteristics (T_J=25 °C, unless otherwise)

Off Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BVDSS	Drain-Source Breakdown Voltage	V _G s=0V , I _D =-250uA	-60			V
△BVDSS/△TJ	BV _{DSS} Temperature Coefficient	Reference to 25°C , ID=-1mA		-0.05		V/°C
	Dunin Course Leakens Cumunt	V _{DS} =-60V , V _{GS} =0V , T _J =25°C			-1	uA
IDSS	Drain-Source Leakage Current	V _{DS} =-48V , V _{GS} =0V , T _J =125°C			-10	uA
Igss	Gate-Source Leakage Current	V _{GS} = ±20V , V _{DS} =0V			±100	nA

On Characteristics

Proyons	R _{DS(ON)} Static Drain-Source On-Resistance V _{GS} =-10V , I _D =-15A V _{GS} =-4.5V , I _D =-10A	Vgs=-10V , Ip=-15A		90	110	mΩ
NDS(ON)		V _{GS} =-4.5V , I _D =-10A		110	150	mΩ
V _{GS(th)}	Gate Threshold Voltage	Vgs=Vps , Ip =-250uA	-1.0	-1.6	-2.5	V
△VGS(th)	V _{GS(th)} Temperature Coefficient			5		mV/°C
gfs	Forward Transconductance	V _{DS} =-10V , I _D =-3A		10		S

Dynamic and switching Characteristics

		<u></u>		
Qg	Total Gate Charge ^{2, 3}		 22.4	
Qgs	Gate-Source Charge ^{2, 3}	Vps=-30V , Vgs=-10V , Ip=-8A	 4.1	 nC
Qgd	Gate-Drain Charge ^{2, 3}		 5.2	
Td(on)	Turn-On Delay Time ^{2, 3}		 13	
Tr	Rise Time ² , ³	V _{DD} =-30V , V _G s=-10V , R _G =6Ω	 42.4	
T _{d(off)}	Turn-Off Delay Time ^{2, 3}		 64.6	 ns
Tf	Fall Time ^{2, 3}		 16.4	
Ciss	Input Capacitance		 1250	
Coss	Output Capacitance	V _{DS} =-30V , V _{GS} =0V , F=1MHz	 85	 pF
Crss	Reverse Transfer Capacitance		 65	

Drain-Source Diode Characteristics and Maximum Ratings

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
ls	Continuous Source Current	V _G =V _D =0V , Force Current			-13	Α
Isм	Pulsed Source Current				-26	Α
Vsp	Diode Forward Voltage	V _G s=0V , I _S =-1A , T _J =25°C			-1.2	V

Note:

5. Repetitive Rating : Pulsed width limited by maximum junction temperature.

6. The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%.

7. Essentially independent of operating temperature.



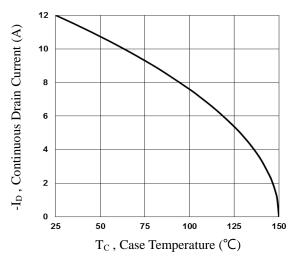


Fig.7 Continuous Drain Current vs. Tc

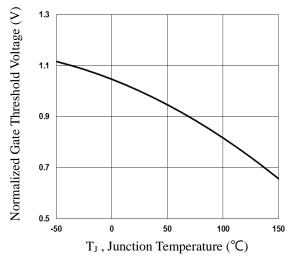


Fig.9 Normalized V_{th} vs. T_J

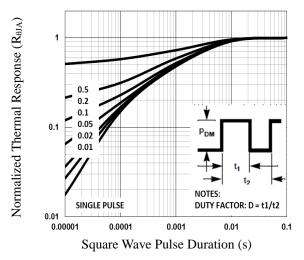


Fig.11 Normalized Transient Impedance

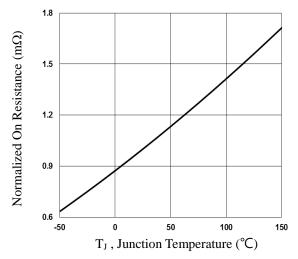


Fig.8 Normalized RDSON vs. T_J

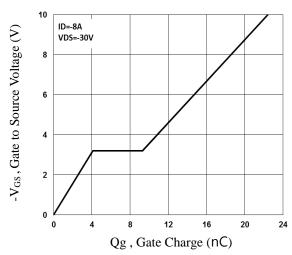


Fig.10 Gate Charge Waveform

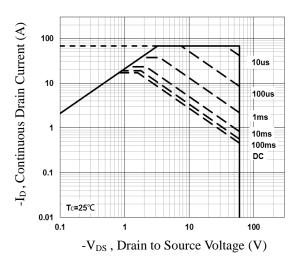
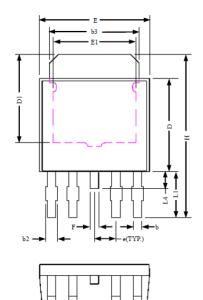


Fig.12 Maximum Safe Operation Area



TO252-4L PACKAGE INFORMATION





		· 4- 1-	- I	G
Symbol	Dimensions In Millimeters		Dimensions In Inches	
	MAX	MIN	MAX	MIN
A	2.400	2.200	0.094	0.087
A1	0.150	0.000	0.006	0.000
В	0.600	0.400	0.024	0.016
b2	0.800	0.500	0.031	0.020
b 3	5.500	5.200	0.217	0.205
C	0.508typ.		0.02typ.	
c2	0.550	0.450	0.022	0.018
D	5.800	5.400	0.228	0.213
D1		4.570		0.180
${f E}$	6.800	6.400	0.268	0.252
E1		3.810		0.150
E	1.27ref.		0.05ref.	
\mathbf{F}	0.600	0.400	0.024	0.016
Н	10.200	9.400	0.402	0.370
L	1.770	1.400	0.070	0.055
L1	3.000	2.400	0.118	0.094
L4	1.200	0.800	0.047	0.031

REELSPECIFICATION

P/N	PKG	QTY
AOD603A-MS	TO-252-4L	2500



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DMN2080UCB4-7 DMN61D9UWQ-13 US6M2GTR DMN31D5UDJ-7 DMP22D4UFO-7B DMN1006UCA6-7 DMN16M9UCA6-7
STF5N65M6 IRF40H233XTMA1 STU5N65M6 DMN6022SSD-13 DMN13M9UCA6-7 DMTH10H4M6SPS-13 DMN2990UFB-7B
IPB80P04P405ATMA2 2N7002W-G MCAC30N06Y-TP MCQ7328-TP NTMC083NP10M5L NVMFS2D3P04M8LT1G BXP7N65D
BXP4N65F AOL1454G WMJ80N60C4 BXP2N20L BXP2N65D BXT1150N10J BXT1700P06M TSM60NB380CP ROG RQ7L055BGTCR
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